EMI TEST REPORT

Test Report No.: 21FE0012-YK-2

Applicant:

Advanced Technology and Systems Co., Ltd.

Type of Equipment:

RAID Subsystem

Model No.:

AXRR-J764SS

Test standard:

FCC Part 15 Subpart B Class B

Test Result:

Complied

- 1. This test report shall not be reproduced except in full, without the written approval of A-Pex International Co., Ltd.
- 2. The results in this report apply only to the sample tested.
- 3. This equipment is in compliance with above regulation. We hereby certify that the data contain a true representation of the EMC profile.
- 4. The test results in this test report are traceable to the national or international standards.
- 5. This test report does not constitute an endorsement by NIST/NVLAP or U.S. Government.

Date of test:

EMI: January 30, 2001

Tested by:

EMI:

Akira Sato EMC section

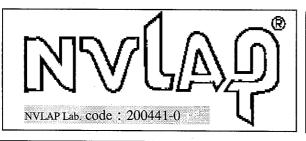
Approved by:

Tetsuya Hashimoto

Director of Yamkita EMC Lab

Date of issue: February 6, 2001

Form Version No.2



This laboratory is registered by the NIST/NVLAP, U.S.A. The tests reported herein have been performed in accordance with its terms of registration.

A-pex International Co., Ltd.

YAMAKITA LAB.

907 Kawanishi, Yamakita-machi, Ashigarakami-gun, Kanagawa-ken, 258-0124 JAPAN

Telephone: Facsimile:

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int +81 465 77 2112 MF060b(27.12.00)

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Issued date : February 6, 2001

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SECTION 1: Client information

Company Name : Advanced Technology and Systems Co., Ltd.

Brand Name : ADTX

Address : 9F East Tower, Yokohama Bisiness Park 134,

Gohdo-cho Hodogaya-ku, yokohama-shi, Kanagawa Japan

Telephone Number : +81-45-334-0040

Facsimile Number : +81-45-334-0094

Contact Person : Tetsushi Kobayashi

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Unique Type Identification: RAID Subsystem

Model No. : AXRR-J764SS

Rating : AC100/240V, 50Hz/60Hz, 150W

Country of Manufacture : JAPAN

Receipt Date of Sample : January 26,27, 2001

2.2 Product description

Advanced Technology and Systems Co., Ltd., Model: AXRR-J764SS (referred to as the EUT in this report) is a RAID Subsystem.

The clock frequency used in EUT is 15MHz, 20MHz, 40MHz, 60MHz, 80MHz.

RAID 0, 1, 0+1, 5

Dual Power Supply

HDD/Power Supply/FAN Hot swap support

Ultra2 SCSI Interface (MAX 40MB/sec translate)

2channel SCSI Interface

AXRR-J764SS has series models.

The way of naming of a series model is as follows.

AXRR-JnnnS **

n:0 to 9, *: Blank or A to Z

AXRR-J764SS is the highest rank model.

See the user's manual Appendix A for the details.

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SECTION 3: Test specification, methods & procedures

3.1 Test specification

Test Specification: FCC Part 15 Subpart B

Title

: FCC 47CFR Part15 Radio Frequency Device

Subpart B Unintentional Radiators (Subpart C Intentional Radiators)

3.2 Methods & Procedures

No.	Item	Test Procedure	Specification	Remarks
1	Conducted emission	FCC/ANSI C63.4:1992	Class B	LISN
2	Radiated emission	FCC/ANSI C63.4:1992	Class B	3m

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating modes

The EUT exercise program used during testing was designed to exercise the various system components in a manner similar to typical use.

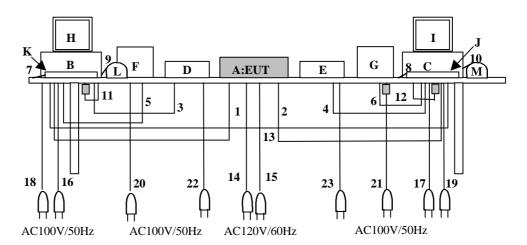
The sequence is used: Random Read/Write

Operation: Windows NT4.0 data file read/write by Xcopy command.

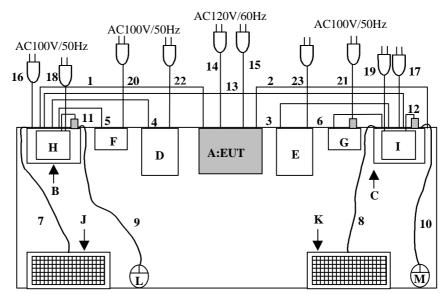
Justification: The system was configured in typical fashion (as a customer would normally use it) for testing.

4.2 Configuration and peripherals

Front View



*Cabling was taken into consideration and test data was taken under worse case conditions. Top View



^{*}Cabling was taken into consideration and test data was taken under worse case conditions.

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Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	FCC ID
Α	RAID Subsystem	AXRR-J764SS	A1DEV#2	ADTX	-
В	Personal Computer	J500C	TYLJQ	DELL	-
C	Personal Computer	J500C	TYLJL	DELL	-
D	Scanner	HPC7190A	SG933160XK	HP	-
Е	Scanner	HPC7190A	SG933160ZC	HP	-
F	Printer	BJF100	-	Canon	-
G	Printer	BJF200	ETF52713	Canon	-
Н	Monitor	E550	2853TPOA4SA9	DELL	JVP7254E
I	Monitor	E550	2853TPOA4RA9	DELL	JVP7254E
J	Keyboard	008436U	38843-9AP-3780	DELL	-
K	Keyborad	008436U	38843-06C-4092	DELL	-
L	Mouse	Intel imouse 1.2A	_	Microsoft	-
M	Mouse	Intel imouse 1.2A	-	Microsoft	

Meshed column are represented EUT

List of cables used

No.	Name	Length (m)	Shield	Backshell material
1	SCSI Cable	12.0	Shielded	P.V.C.
2	SCSI Cable	12.0	Shielded	P.V.C.
3	USB Cable	1.8	Shielded	P.V.C.
4	USB Cable	1.8	Shielded	P.V.C.
5	Parallel Cable	2.0	Unshielded	P.V.C.
6	Parallel Cable	2.0	Unshielded	P.V.C.
7	Keyboard Cable	2.1	Shielded	P.V.C.
8	Keyboard Cable	2.1	Shielded	P.V.C.
9	Mouse Cable	1.8	Unshielded	P.V.C.
10	Mouse Cable	1.8	Unshielded	P.V.C.
11	Monitor Cable	1.8	Shielded	P.V.C.
12	Monitor Cable	1.8	Shielded	P.V.C.
13	Serial Cable	3.0	Unshielded	P.V.C.
14	AC Cable	1.8	Unshielded	P.V.C.
15	AC Cable	1.8	Unshielded	P.V.C.
_16	AC Cable	1.8	Unshielded	P.V.C.
17	AC Cable	1.8	Unshielded	P.V.C.
18	AC Cable	1.8	Unshielded	P.V.C.
19	AC Cable	1.8	Unshielded	P.V.C.
20	AC Cable	1.8	Unshielded	P.V.C.
21	AC Cable	1.8	Unshielded	P.V.C.
22	AC Cable	1.8	Unshielded	P.V.C.
23	AC Cable	1.8	Unshielded	P.V.C.

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SECTION 5: Summary of test results

5.1 Test results

No.	Item	Test Procedure	Specification	Remarks	Results
1	Conducted emission	FCC/ANSI C63.4:1992	Class B	LISN	Complied
2	Radiated emission	FCC/ANSI C63.4:1992	Class B	3m	Complied

A-PEX INTERNATIONAL hereby confirms that E.U.T., in the configuration tested, complies with the specifications FCC Part15 Subpart B.

5.1.1 Data of conducted emission test

The initial step in collecting conducted data is a spectrum analyzer peak scan of the measurement range (450KHz-30MHz).

The final data represents worst-case emissions.

The minimum margin to the limit is as follows:

Power Line for: AC1

Frequency (MHz)	Line (N/L)	Receiver Reading (dBuV)	LISN Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)
8.6017	L1	42.2	0.4	43.5	48.0	4.5
Power Line for	r:AC2				,	
Frequency (MHz)	Line (N/L)	Receiver Reading (dBuV)	LISN Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)
8.9809	L1	44.1	0.4	45.5	48.0	2.5

^{*} All readings are quasi-peak mode.

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^{*} LISN Factor = include Cable loss.

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5.1.2 Data of radiated emission test

The initial step in collecting radiated data was a spectrum analyzer peak scan of the measurement range (30MHz-1000MHz).

The final data was reported in the worst-case emissions.

The minimum margin to the limit is as follows:

Frequency (MHz)	Receiver Reading (dBuV)	Correction Factor (dB/m)	Field Strength (dBuV/m)	Limit (dBuV/m)	Margin (dB)
95.95	50.0	-9.8	40.2	43.5	3.3

^{*} All readings are quasi-peak mode.

Field strength calculation

The field strength is calculated by adding the Antenna Factor, Cable Factor and Antenna Pad, and subtracting the Amplifier Gain from the measured reading. The sample calculation is as follows:

$$FS = RA + \underline{AF + CF + AT - AG}$$

Correction factor

where FS = Field Strength

RA = Receiver Amplitude

AF = Antenna Factor

CF = Cable Factor

AT = Antenna Pad

AG = Amplifier Gain

Assume a receiver reading of 50.0dBuV is obtained. The antenna Factor of 10.0dB, Cable Factor of 2.4dB and Antenna Pad of 6.0dB is added.

The Amplifier Gain of 28.2dB is subtracted, giving a field strength of 40.2dBuV/m.

$$FS = 50.0 + 10.0 + 2.4 + 6.0 - 28.2 = 40.2 dBuV/m$$

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5.2 Uncertainty

Conducted emission test

The measurement uncertainty (with a 95% confidence level) for this test was ± 2.0 dB.

The data listed in this test report has enough margin, more than 2.0dB.

Radiated emission test

The measurement uncertainty (with a 95% confidence level) for this test was ± 3.3 dB.

The data listed in this test report has enough margin, more than 3.3dB.

5.3 Test instruments

Refer to SECTION 6: TEST INSTRUMENTS

5.4 Test location

A-PEX International Co.,Ltd. Yamakita No.1 Open Test Site.

907, Kawanishi, Yamakita-machi, Ashigarakami-gun, Kanagawa-ken 258-0124 Japan

Telephone number : +81-465-77-1011 Facsimile number : +81-465-77-2112

This site has been fully described in a report dated September 24, 1999 submitted to FCC office, and accepted in a letter

dated October 8, 1999 (95486)

* NVLAP Lab. code: 200441-0

5.5 Photographs of test setup

Refer to Appendix 1.

5.6 Data of EMI test

Refer to Appendix 2.

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SECTION 6: Test instruments

EMI test instrument

Instrument	Manufacturer	Model No.	Control No.	Calibration date / Interval
Pre-Amplifier	Hewlett Packard	8447D	KAF-01	September 5, 2000 / 1year
Biconical Antenna	Schwarzbeck	BBA9106	KBA-01	September 3, 2000 / 1year
Logperiodic Antenna	Schwarzbeck	USLP9143	KLA-02	September 3, 2000 / 1year
LISN	Schwarzbeck	NSLK8126	KLS-01	September 7, 2000 / 1year
LISN	Schwarzbeck	NSLK8127	KLS-02	September 7, 2000 / 1year
LISN	Schwarzbeck	NSLK8129	KLS-06	January 9, 2001 / 1year
Pulse Limitter	PMM	PL-01	KPL-01	September 15, 2000 / 1year
Spectrum Analyzer	ADVANTEST	R3265	KSA-02	December 10, 2000 / 1year
Test Receiver	Rohde & Schwarz	ESCS30	KTR-02	December 4, 2000 / 1year

^{*}All equipment is calibrated with traceable calibrations. Each calibration is traceable to the national or international standards.

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SECTION 7: Conducted emission

7.1 Operating environment

The test was carried out in a shielded room 8.0 x 5.0 x 2.5m.

Temperature : 20 degree Humidity : 33 %

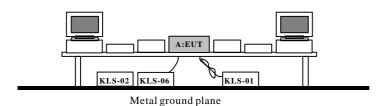
7.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane.

The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flush with rear of tabletop. All other surfaces of tabletop was at least 80cm from any other grounded conducting surface. I/O cables and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. Each EUT current-carrying power lead, except the ground (safety) lead, were individually connected through a LISN to the input power source. All unused 50ohm connectors of the LISN were resistively terminated in 50ohm when not connected to the measuring equipment.

A drawing of the set up is shown in fig. 1 and the photos of Appendix 1.

Figure 1. Drawing of the test set-up



7.3 Test conditions

Frequency range : 0.45MHz-30MHz

EUT position : Table top

7.4 Test procedure

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT within a screened room. The EUT was connected to a Line Impedance Stabilization Network (LISN). An overview sweep with peak detection has been performed. The measurements have been performed with a quasi-peak detector and if required, with an average detector.

The EUT was put into operation at Random Read/Write mode .

7.5 Results

Summary of the test results: Pass

Date: January 30, 2001 Test engineer: A. Sato

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SECTION 8: Radiated emission

8.1 Operating environment

The test was carried out in an open test site.

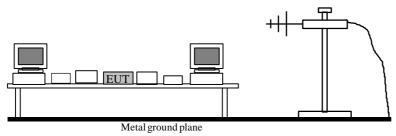
Temperature : 17 degree Humidity : 38 %

8.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The rear of EUT, including peripherals was aligned and flush with rear of tabletop.I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged 40cm height to the ground plane. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.

A drawing of the set up is shown in fig. 2 and the photos of Appendix 1.

Figure 2. Drawing of the test set-up



8.3 Test conditions

Frequency range : 30MHz - 1000MHz

Test distance : 3m EUT position : Table top

8.4 Test procedure

The Radiated Electric Field Strength intensity has been measured on an open test site with a ground plane and at a distance of 3m.

Pre check measurements were performed within a screened room or used search coil for ambient noise at high-level, especially from 272MHz to 288MHz. Measurements were performed with a quasi-peak detector.

The measuring antenna height was varied between 1 to 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for both vertical and horizontal antenna polarization. The EUT was put into operation at Random Read/Write mode.

8.5 Results

Summary of the test results: Pass

Date: January 30, 2001 Test engineer: A. Sato

A-pex International Co., Ltd. YAMAKITA LAB.

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APPENDIX 1: Photographs of test setup

This section contains the following photographs:

Page 14: Conducted emission

Page 15: Radiated emission

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Conducted emission



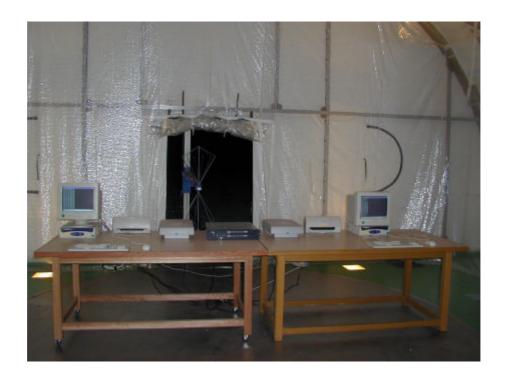


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Radiated emission





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APPENDIX 2: Data of EMI test

This section contains the following data

Conducted emission : Power Line for AC1 <u>A2-01 to A2-03</u>

Power Line for AC2 A2-04 to A2-06

Radiated emission: A2-07 to A2-08

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DATA OF CONDUCTION TEST

Engineer

A-PEX INTERNATIONAL CO., LTD.

Yamakita No.1 Open Test Site Report No.: 21FE0012-YK-2

Applicant : Advanced Technology and Systems Co., Ltd

Kind of Equipment : RAID Subsystem
Model No. : AXRR-J764SS
Serial No. : A1DEV#2
Power : AC120V/60Hz
Mode : Random Read/Write

Remarks : AC-1

Date : 1/30/2001 Phase : Single Phase

Temperature : 20 °C Humidity : 33 %

Regulation : FCC Part15B CLASS B

No. FREQ. READING (N) READING (L1) LISN CABLE ATTEN. RESULT LIMITS MARGIN QΡ ΑV AV FACTOR LOSS QΡ QΡ QP AV AV ΑV [dBuV] [dBuV] [MHz][dB][dB] [dB][dBuV] [dBuV] [dB] 0.5019 37.2 0.4 0.2 1. 36.7 0.0 37.8 48.0 0.0 10.2 2. 0.701736.7 36.2 0.2 0.0 0.4 37.3 48.0 0.0 10.7 3. 0.3 0.0 1.5820 38.8 35.0 0.3 39.4 8.6 48.0 0.0 3.3570 4. 38.3 36.3 0.3 0.4 0.0 39.0 48.0 9.0 0.0 5. 6.8357 34. 5 32.4 0.4 0.8 0.0 35.7 48.0 0.0 12.3 6. 8.6017 39.0 42.2 0.4 0.9 0.043.5 48.0 0.0 4.5

CALCULATION: READING + LISN FACTOR + CABLE LOSS + ATTEN.

■LISN: KLS-01 (NSLK8126) ■ COAXIAL CABLE: KCC-14/15/16/18
■PULSE LIMITTER: KPL-01 (PL01) ■ EMI RECEIVER: KTR-02 (ESCS30)

DATA OF CONDUCTION TEST

A-PEX INTERNATIONAL CO., LTD.

Yamakita No.1 Open Test Site Report No.: 21FE0012-YK-2

Applicant

: Advanced Technology and Systems Co., Ltd

Kind of Equipment

RAID Subsystem

Model No. Serial No. AXRR-J764SS A1DEV#2 AC120V/60Hz

Power

Random Read/Write

Mode Remarks

Date Phase AC-1 1/30/2001 Single Phase

Temperature Humidity

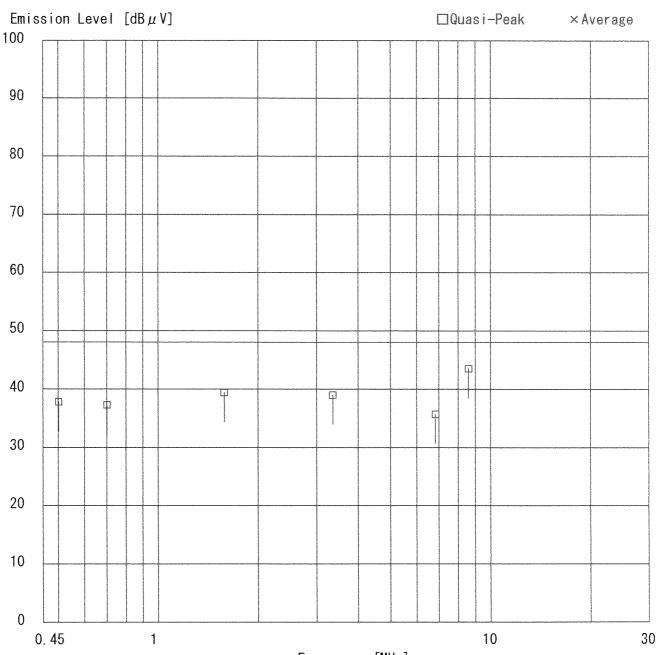
20 °C 33 %

Engineer

: Akira Sato

a. Sato

Regulation : FCC Part15B CLASS B



Frequency [MHz]

Page: A 2 - 0

DATA OF CONDUCTION TEST CHART

A-PEX INTERNATIONAL CO., LTD.

Yamakita No.1 Open Test Site Report No.: 21FE0012-YK-2

Applicant

: Advanced Technology and Systems Co., Ltd

Kind of Equipment: RAID Subsystem
Model No. : AXRR-J764SS
Serial No. : A1DEV#2 Power

: AC120V/60Hz

Mode Remarks Random Read/Write AC-1

Date Phase

1/30/2001 : Single Phase : 20 °C

Temperature Humidity

: 33 %

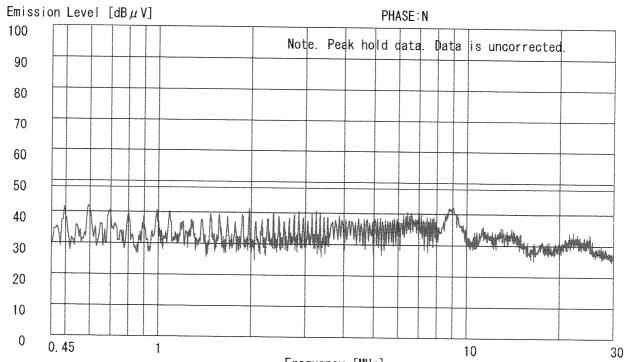
Engineer : Akira Sato

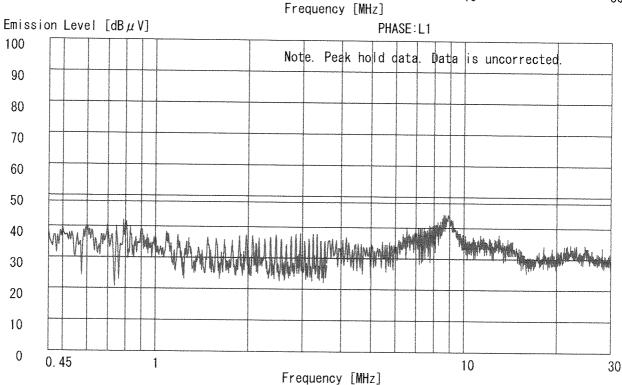
Regulation 1

: FCC Part15B CLASS B

Regulation 2

: None





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DATA OF CONDUCTION TEST

A-PEX INTERNATIONAL CO., LTD. Yamakita No.1 Open Test Site

Report No.: 21FE0012-YK-2

Advanced Technology and Systems Co., Ltd Applicant

Kind of Equipment RAID Subsystem AXRR-J764SS A1DEV#2 AC120V/60Hz Model No. Serial No. Power

Random Read/Write Mode

AC-2 Remarks

1/30/2001 Date Single Phase Phase

20 °C 33 % Engineer Temperature

Humidity : FCC Part15B CLASS B Regulation

No.	FREQ.	READING QP [dBuV	AV	READIN QP [dBu	AV	LISN FACTOR [dB]		ATTEN.	RESU QP [dBu/	AV	LIM] QP [dBu\	AV	MARG QP [dB	AV
1. 2. 3. 4. 5. 6.	0. 4960 0. 8494 1. 1868 2. 9630 6. 7134 8. 9809	40. 3 37. 1 37. 2 36. 6 38. 2 41. 5		37. 5 39. 8 35. 3 35. 1 36. 4 44. 1		0. 4 0. 3 0. 3 0. 3 0. 4 0. 4	0. 1 0. 2 0. 2 0. 4 0. 7 1. 0	0. 0 0. 0 0. 0 0. 0 0. 0	40. 8 40. 3 37. 7 37. 3 39. 3 45. 5		48. 0 48. 0 48. 0 48. 0 48. 0 48. 0	0. 0 0. 0 0. 0 0. 0 0. 0 0. 0	7. 2 7. 7 10. 3 10. 7 8. 7 2. 5	

CALCULATION: READING + LISN FACTOR + CABLE LOSS + ATTEN.

■LISN: KLS-01 (NSLK8126) ■ COAXIAL CABLE: KCC-14/15/16/18 ■PULSE LIMITTER: KPL-01 (PL01) ■ EMI RECEIVER: KTR-02 (ESCS30)

DATA OF CONDUCTION TEST

Engineer

A-PEX INTERNATIONAL CO., LTD.

Yamakita No.1 Open Test Site Report No.: 21FE0012-YK-2

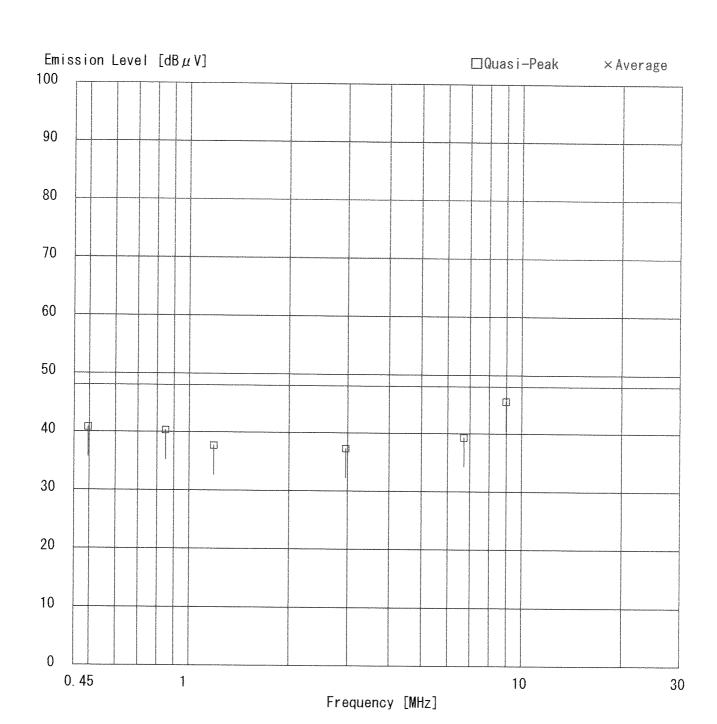
Applicant Advanced Technology and Systems Co., Ltd

Kind of Equipment RAID Subsystem Model No. AXRR-J764SS A1DEV#2 AC120V/60Hz Serial No. Power Mode Random Read/Write

Remarks AC-2 Date 1/30/2001 : Single Phase : 20 °C : 33 % Phase

Temperature Humidity

Regulation : FCC Part15B CLASS B



DATA OF CONDUCTION TEST CHART

A-PEX INTERNATIONAL CO., LTD.

Yamakita No.1 Open Test Site Report No.: 21FE0012-YK-2

Applicant : Advanced Technology and Systems Co., Ltd

Kind of Equipment : RAID Subsystem Model No. : AXRR-J764SS Serial No. A1DEV#2 Power AC120V/60Hz

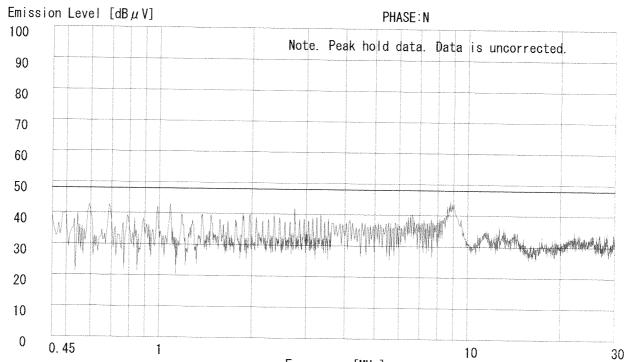
Mode : Random Read/Write

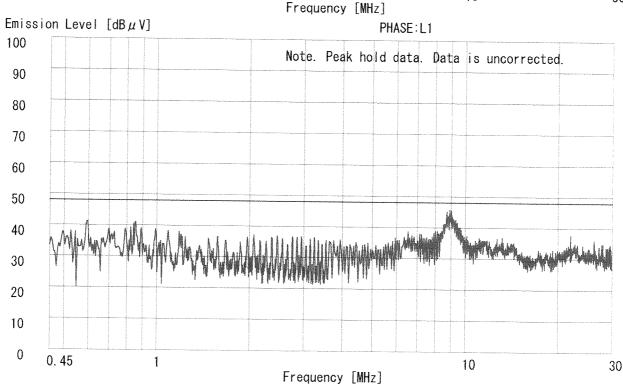
Remarks AC-2 Date 1/30/2001 Single Phase 20 °C Phase Temperature

Engineer Humidity 33 %

: None

Regulation 1 : FCC Part15B CLASS B Regulation 2





Page: A 2 - N G

DATA OF RADIATION TEST

Engineer

A-PEX INTERNATIONAL CO., LTD.

Yamakita No.1 Open Test Site Report No.: 21FE0012-YK-2

Applicant Advanced Technology and Systems Co., Ltd

Kind of Equipment RAID Subsystem AXRR-J764SS A1DEV#2 AC120V/60Hz Model No. Serial No. Power

Random Read/Write Mode

Remarks

1/30/2001 Date

3 m Test Distance 17 °C 38 % Temperature

Humidity

: FCC Part15B CLASS B Regulation

No.	FREQ.	ANT TYPE	REAL HOR [db]	DING VER μV]	ANT FACTOR [dB/m]	AMP GAIN [dB]	CABLE LOSS [dB]	ATTEN. [dB]	RESI HOR [dB μ '	VER_	LIMITS BμV/m]	HOR	RGIN VER HB]
1. 2. 3. 4. 5. 6. 7. 8.	43. 50 49. 99 71. 36 95. 95 192. 00 300. 00 359. 98 420. 01	BB BB BB BB BB BB BB	40. 0 38. 4 49. 0 50. 0 34. 9 35. 7 33. 2 29. 3	44. 6 46. 5 50. 4 49. 0 33. 3 37. 2 33. 8 33. 1	12. 5 9. 8 6. 3 10. 0 16. 8 14. 5 16. 4	28. 3 28. 3 28. 2 28. 2 28. 0 27. 6 28. 1 28. 6	2. 4 3. 5 4. 6 5. 1	6. 0 6. 0 6. 0 6. 0 6. 0 6. 1 6. 1	31. 8 27. 6 35. 2 40. 2 33. 2 33. 3 32. 7 30. 1	36. 4 35. 7 36. 6 39. 2 31. 6 34. 8 33. 3 33. 9	40. 0 40. 0 40. 0 43. 5 43. 5 46. 0 46. 0	8. 2 12. 4 4. 8 3. 3 10. 3 12. 7 13. 3 15. 9	3. 6 4. 3 3. 4 4. 3 11. 9 11. 2 12. 7 12. 1

CALCULATION: READING + ANT. FACTOR + CABLE LOSS - AMP. GAIN + ATTEN.

■ ANTENNA: KBA-01 (BBA9106) 30-299. 99MHz/KLA-02 (USLP9143) 300-1000MHz

■ CABLE: KCC-10/11/12/13/18 ■ PREAMP: KAF-01 (8447D) ■ EMI RECEIVER: KTR-02 (ESCS30)

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DATA OF RADIATION TEST

A-PEX INTERNATIONAL CO., LTD.

Yamakita No.1 Open Test Site Report No.: 21FE0012-YK-2

Applicant : Advanced Technology and Systems Co., Ltd

Kind of Equipment : RAID Subsystem Model No. : AXRR-J764SS

Model No. : AXRR-J/6488
Serial No. : A1DEV#2
Power : AC120V/60Hz
Mode : Random Read/

Mode : Random Read/Write Remarks :

Date : 1/30/2001

Test Distance : 3 m

Temperature : 17 °C Engineer : Akira Sato

Humidity : 38 %

Regulation : FCC Part15B CLASS B

